

EMC TEST REPORT

Project No.	LBE20172154	Issue No.	0
Applicant	Name of organization	Samsung Electronics Co., Ltd.	
	Address	(Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Republic of Korea	
	Date of application	October 11, 2017	
EUT	Type of device	☒ Class B personal computers and peripherals ☐ All other devices	
	Equipment authorization	☐ Declaration of Conformity ☒ Certification ☐ Verification	
	FCC ID	A3LSMJ250F	
	Kind of product	Mobile Phone	
	Model No.	SM-J250F/DS	
	Variant Model No.	Refer to clause 4.6	
	Manufacturer	Samsung Electronics CO., LTD 94-1, Imsu-dong, Gumi-si, Gyengsangbuk-do, 730-722, Republic of Korea Samsung Electronics Huizhou CO.,LTD. 516229, Chenjiang Town, HuiZhou City, Guangdong Province, China	
Applied Standards		47 CFR Part 15, Subpart B, Class B / ANSI C63.4-2014	
Test Period		October 16, 2017 ~ October 23, 2017	
Issue date		October 27, 2017	
Test result : Complied The equipment under test has found to be compliant with the applied standards. (Refer to the attached test result for more detail.)			
Tested by : Soo-Joon Kim 		Reviewed by : Hee-sung Kim 	

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Global CS Center of Samsung Electronics Co., Ltd.
 (Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Republic of Korea

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1. Report Information

1.1 Revision history

No.	Revised detailed information
Issue 0	There are no revisions and this version is basic test report.

2. Summary of test results

2.1 Emission

The EUT has been tested according to the following specifications:

Applied	Test type	Applied standard	Result
☒	Conducted Disturbance (Mains port)	47 CFR Part 15 Subpart B / ANSI C63.4-2014 (Class B)	Complied
☒	Radiated Disturbance		Complied

3. General Information

3.1 Test facility

The Global CS Center is located on Samsung Electronics Co., Ltd. at (Maetan-dong) 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Republic of Korea.

All testing are performed in Semi-anechoic chambers conforming to the site attenuation characteristics defined by ANSI C63.4, CISPR 32, CISPR 16-1-4 and Shielded rooms.

And all antennas are properly calibrated using ANSI C63.5:2006.

The Global CS Center is operated as testing laboratory in accordance with the requirements of ISO/IEC 17025:2005.

4. Test Setup configuration

4.1 Test Peripherals

The cables used for these peripherals are either permanently attached by the peripheral manufacturer or coupled with an assigned cable as defined below.

The following is a listing of the EUT and peripherals utilized during the performance of EMC test:

Mark	Description	Model No.	Serial No.	Manufacturer / Trademark	FCC ID / DoC
A	Mobile Phone	SM-J250F/DS	-	SAMSUNG	A3LSMJ250F
B	Battery	EB-BG530CBE	-	SAMSUNG	-
C	Headset	EHS61ASFWE	-	SAMSUNG	-
D	Data Cable	ECB-DU68WE	-	SAMSUNG	-
E	Micro SD Card	32GB	-	SAMSUNG	-
F	Desk-Top Computer	DM-C410	HFGD97AB700278X	SAMSUNG	DoC
		DM300S	A20100622	SAMSUNG	DoC
G	LCD TV Monitor	PE22BS	N849HVMP702249R	SAMSUNG	DoC
		EM23TS	NC26H1KSB01550B	SAMSUNG	DoC
H	Mouse	SML-210PB	TAKD125024 V	SAMSUNG	DoC
			TAKD124911 M	SAMSUNG	DoC
I	Keyboard	SDM8500P	8M001183	SAMSUNG	DoC
			8M001033	SAMSUNG	DoC
J	Gigabit Switch 8	J9794A	CN33FQ703Q	HP	DoC
			CN33FQ71XK	HP	DoC
K	Power Supply	EADP-15DC A	DIKD1245096741	Delta	DoC
			DIKD1245096576	Delta	DoC

4.2 EUT operating mode

To achieve compliance applied standard specification, the following mode(s) were made during compliance testing:

Operating Mode 1	USB Mode (Data Communication)
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4.3 Details of Sampling

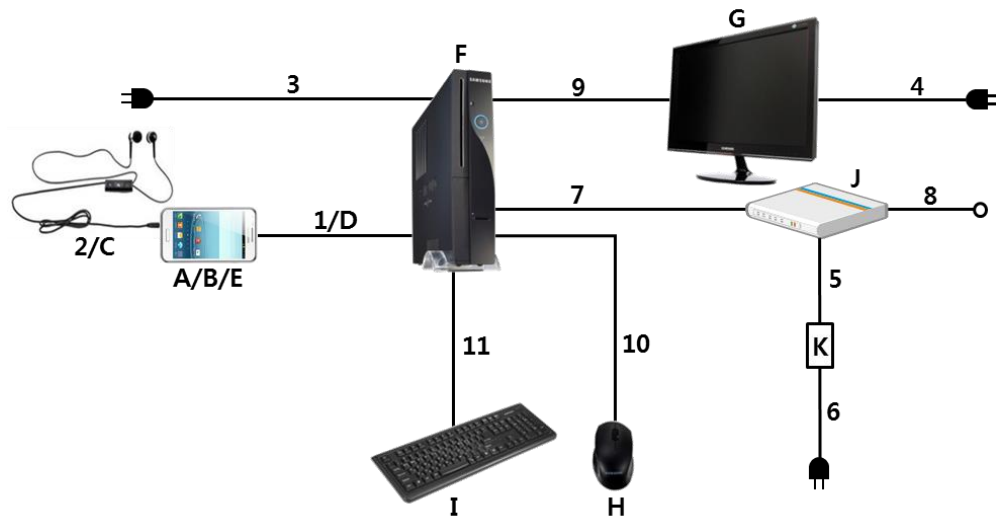
Customer selected, single unit.

4.4 Used cable description

The EUT is configured, installed, arranged and operated in a manner consistent with typical applications. Interface cables/loads/devices are connected to at least one of each type of interface port of the EUT, and where practical, each cable shall be terminated in a device typical of actual usage. The type(s) of interconnecting cables to be used and the interface port (of the EUT) to which these were connected:

No.	Connected cable	Length [m]	Shielded [Y/N]	Note
1	Data Cable	0.8	Yes	From EUT to Desk-Top Computer
2	Headset	1.6	No	For EUT
3	Power	1.8	No	For Desk-Top Computer
4	Power	1.8	No	For LCD TV Monitor
5	Power	1.8	No	From Gigabit Switch 8 to Power Supply
6	Power	1.8	No	For Power Supply
7	LAN	1.5	No	From Desk-Top Computer to Gigabit Switch 8
8	LAN	1.5	No	From Gigabit Switch 8 to Local Area Network
9	RGB	1.8	Yes	From Desk-Top Computer to LCD TV Monitor
10	PS/2	1.5	Yes	From Desk-Top Computer to Mouse
11	PS/2	1.5	Yes	From Desk-Top Computer to Keyboard

4.5 Test arrangement



4.6 EUT Description

The EUT is a bar type Mobile Phone which can operate on GSM850/900/1800, WCDMA FDD1/5/8, LTE FDD1/3/5/7/8/20, LTE TDD38/40 bands and Incorporates a camera, Bluetooth, Wi-Fi, GPS, FM Radio and MP3/MP4 player.

4.6.1 The variant models

- SM-J250F

4.7 EUT Frequencies

The highest frequencies (Generated and used)	Frequency [MHz]
CPU	1 400
LTE TDD38	2 620

4.8 Test configuration and condition

- ☐ The EUT exercise program which is the samsung standardized emission test program for Windows was used during all EMC measurements were tested. This program was contained on the PC hard disk drive. Once loaded, the program sequentially exercises each system component in turn.
- ☒ The EUT was exercised during the testing by data read and write cycles repeated with internal/external storage devices. At the end of the test, the copied back data was compared with origin
- ☐ The EUT was connected to the PC by using USB data cable to charge.
- ☐ The system was configured for testing in a typical fashion that a customer would normally use, and was tested while in an automated non-attendant mode.

Power source for the EUT operating was supplied by CVCF made by the Pacific Power Source Corp.

- Test Voltage : AC 120 V, 60 Hz

4.9 Measurement uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the apparatus: (According to CISPR 16-4-2 and UKAS M3003)

4.9.1 Emission

Test type		Measurement uncertainty (C.L. 95 %, k = 2)
Conducted disturbance	AC Mains	3.47 dB
Radiated Disturbance (30 MHz ~ 1 GHz)	Horizontal	4.99 dB
	Vertical	4.90 dB
Radiated Disturbance (1 GHz ~ 6 GHz)	Horizontal	4.85 dB
	Vertical	4.84 dB
Radiated Disturbance (6 GHz ~ 18 GHz)	Horizontal	5.30 dB
	Vertical	5.30 dB

5. Results of individual test

5.1 Conducted disturbance

The EUT was connected to the Desk-Top Computer which was powered from one LISN for the measurements. The support equipment power cables were connected to a second LISN.

Both conducted lines are measured in Quasi-Peak and CISPR-Average mode, including the worst-case data points for each tested configuration. The EUT measured in accordance with the methods described in standards.

Limits for conducted disturbance at the mains ports of Class B ITE

Frequency range Limits [MHz]	Resolution Bandwidth [kHz]	Limits [dB(μV)]	
		Quasi-peak	Average
0,15 to 0,50	9	66 to 56	56 to 46
0,50 to 5	9	56	46
5 to 30	9	60	50

NOTE 1 The lower limit shall apply at the transition frequency.
NOTE 2 The limit decreases linearly with the logarithm of the frequency in the range 0.15 MHz to 0.50 MHz.

5.1.1 Test instrumentation

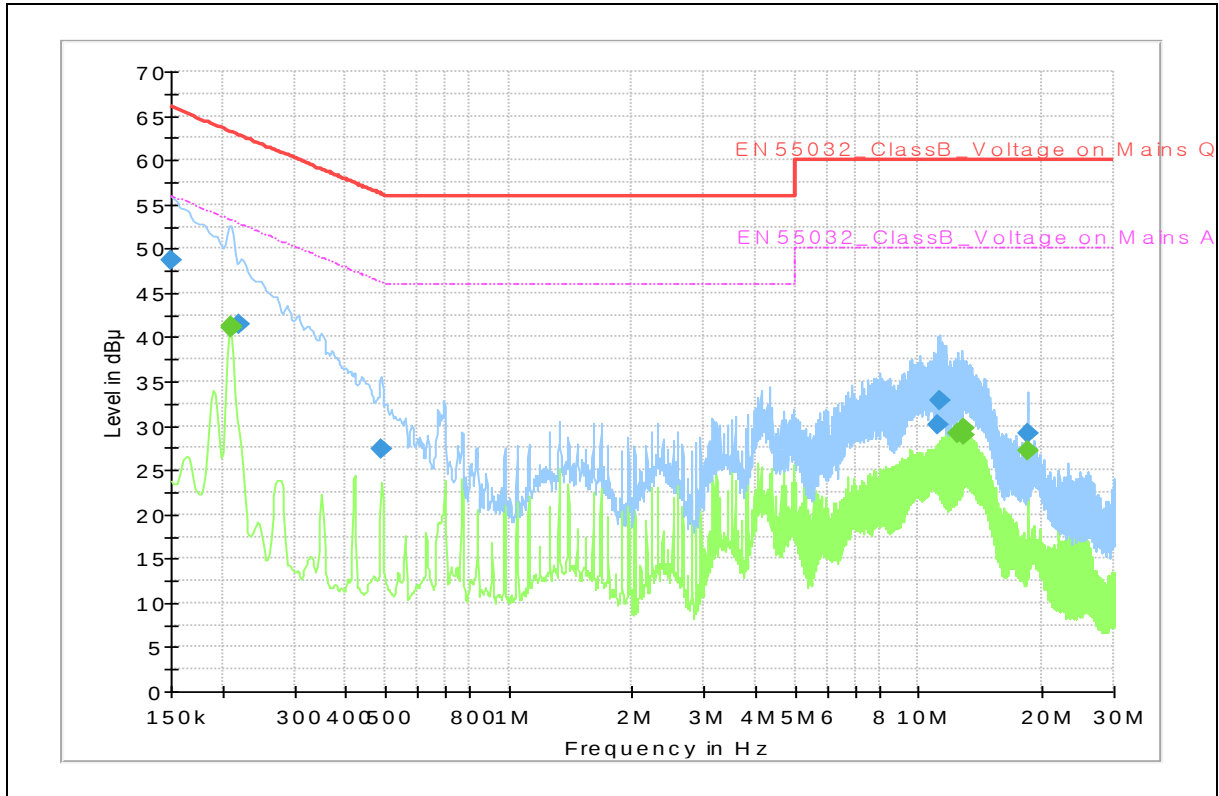
EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-043	LISN	ENV216	R&S	101630	2017-08-09	12
E5I-129	LISN	ENV216	R&S	102061	2017-07-18	12
E5I-123	EMI Test Receiver	ESU8	R&S	100475	2017-05-08	12
-	Test software	EMC32	R&S	Ver 9.26.01	-	-

5.1.2 Temperature and humidity condition

Test date	2017-10-16	Test engineer	Soo-Joon Kim
Climate condition	Ambient temperature	(24.4 ~ 24.5) °C	Limit (15.0 to 35.0) °C
	Relative humidity	(43.4 ~ 44.9) % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	(102.3 ~ 102.4) kPa	Limit (86.0 to 106.0) kPa
Test place	Shield Room (SR8)		

5.1.3 Test results

☐ Operating Mode 1: AC Mains



Note 1) Two graphs measured for both Live(L1) and Neutral(N) of the LISN are combined into one graph.

QP / CAV final measurement results table:

Frequency (MHz)	QP (dBμV)	CAV (dBμV)	Limit (dBμV)	Margin (dB)	Line	Corr. (dB)
0.150	48.7	---	66.0	17.3	N	9.9
0.210	---	41.2	53.2	12.0	L1	10.1
0.210	---	41.1	53.2	12.1	L1	10.1
0.219	41.5	---	62.9	21.4	L1	10.0
0.487	27.3	---	56.2	28.9	N	10.2
11.136	30.1	---	60.0	29.9	N	10.3
11.278	32.8	---	60.0	27.2	N	10.3
12.450	---	29.1	50.0	20.9	N	10.4
12.838	---	28.9	50.0	21.1	L1	10.4
12.907	---	29.7	50.0	20.3	L1	10.4
18.536	29.1	---	60.0	30.9	L1	10.6
18.544	---	27.1	50.0	22.9	N	10.7

Note 2) Level (QP and/or CAV) = Meter Reading (QP and/or CAV) + Corr. (LISN Insertion Loss + Cable Loss)

Margin (QP and/or CAV) = Limit – Level (QP and/or CAV)

QP = Quasi-Peak, CAV = CISPR-Average, Corr. = Correction Factor

5.2 Radiated disturbance

The following data lists the significant emission frequencies, measured levels, correction factors (for antenna and cables), orientation of table, polarization and height of antenna, the corrected reading, the limit, and the amount of margin.

Peak measurements were made over the changeable frequency range 30 MHz to 1 GHz at a measurement distance of 10 m for the following antenna and turntable arrangements:

Antenna Height [cm]	Antenna Polarisation	Resolution Bandwidth [kHz]	Video Bandwidth [kHz]	Turntable position [degrees]
100 ~ 400	Horizontal, Vertical	120	300	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using quasi-peak detector.

Peak/CISPR-Average measurements were made over the changeable frequency range 1 GHz to 40 GHz or 5th harmonics of the highest frequency generated or used in the device or on which the device operate or tunes at a measurement distance of 3 m for the following antenna and turntable arrangements. The measurements above 1 GHz were performed with the bore-sighting antenna aimed at the EUT.

Antenna Height [cm]	Antenna Polarisation	Resolution Bandwidth [MHz]	Video Bandwidth [MHz]	Turntable position
100 ~ 400	Horizontal, Vertical	1	3	Continuous

Measurements within 6 dB of the limit were then maximized by adjusting turntable position. Final measurements were made using peak and CISPR-average detectors.

Limits for radiated disturbance of Class B ITE at a measuring distance of 3 m and 10 m

Frequency range Limits [MHz]	Field Strength		
	3 m [$\mu\text{V/m}$]	3 m [dB($\mu\text{V/m}$)]	10 m [dB($\mu\text{V/m}$)]
30 to 88	100	40.0	29.5
88 to 216	150	43.5	33.0
216 to 960	200	46.0	35.5
Above 960	500	54.0	43.5

Results checked manually; and points close to the limit line were re-measured.

5.2.1 Test instrumentation

EMC No.	Test Instrument	Model name	Manufacturer	Serial No.	Calibration	
					Date	Interval (Month)
E5I-015	EMI Test Receiver	ESU8	R&S	100481	2017-06-21	12
E5I-020	EMI Test Receiver	ESU40	R&S	100375	2017-08-22	12
E5I-035	Horn Antenna	HF907	R&S	100506	2017-05-16	24
E5I-121	BiLog Antenna	CBL6112D	TESEQ	36999	2016-08-18	24
E5I-072	BiLog Antenna	CBL6112D	TESEQ	36009	2017-05-31	24
E5I-039	Signal Conditioning Unit	SCU-18	R&S	10211	2017-01-24	12
E5I-075	Preamplifier	310N	SONOMA	332018	2017-05-22	12
E5I-076	Preamplifier	310N	SONOMA	332019	2017-05-28	12
-	Test software	EP7RE	TOYO	Ver 5.8.2	-	-
-	Test software	EMC32	R&S	Ver 9.25.00	-	-

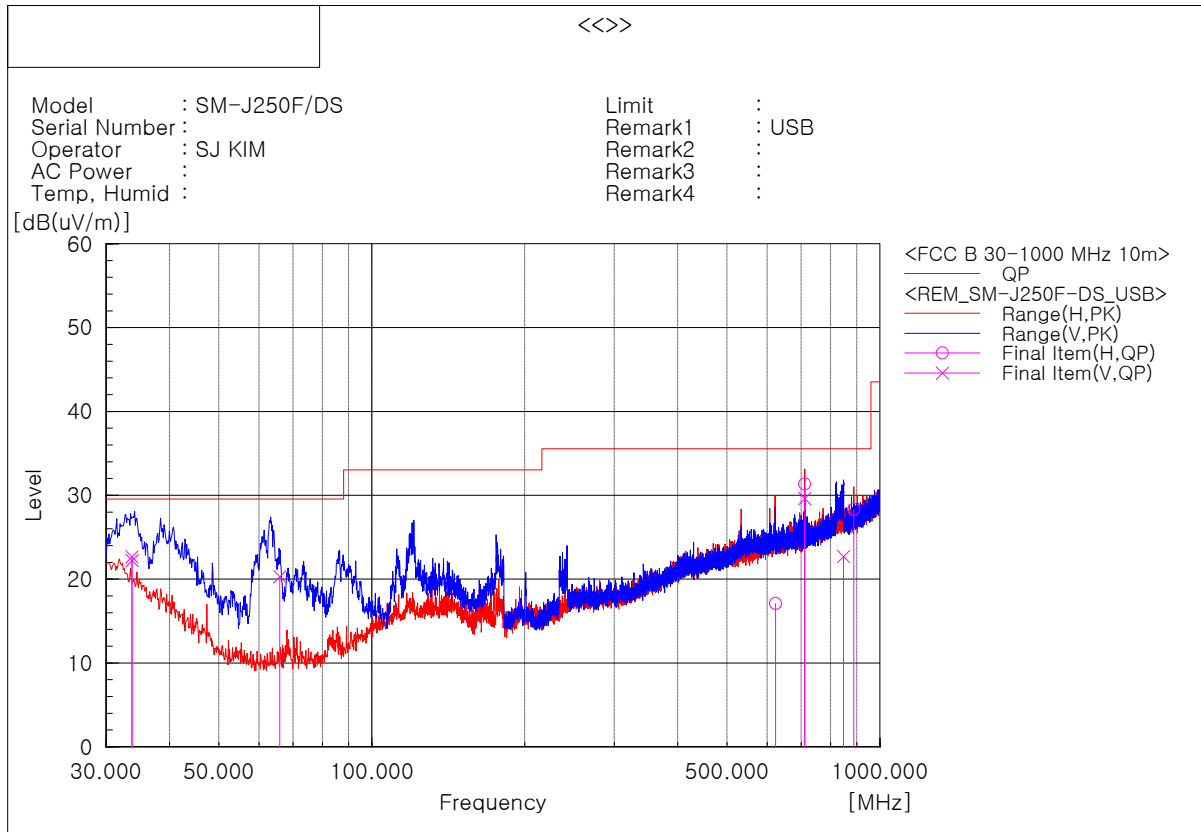
5.2.2 Temperature and humidity condition

Test date	2017-10-23	Test engineer	Soo-Joon Kim
Climate condition	Ambient temperature	(22.5 ~ 23.1) °C	Limit (15.0 to 35.0) °C
	Relative humidity	(49.0 ~ 50.0) % R.H.	Limit (25.0 to 75.0) % R.H.
	Atmospheric pressure	(101.3 ~ 101.5) kPa	Limit (86.0 to 106.0) kPa
Test place	Semi-Anechoic Chamber (SAC4)		

5.2.3 Test results

☐ Operating Mode 1

- Frequencies below 1 GHz



Final Result

No.	Frequency [MHz]	(P)	Reading QP [dB(uV)]	c.f [dB(1/m)]	Result QP [dB(uV/m)]	Limit QP [dB(uV/m)]	Margin QP [dB]	Height [cm]	Angle [deg]	System
1	33.712	V	31.4	-8.7	22.7	29.5	6.8	100	303	2
2	33.725	V	30.9	-8.7	22.2	29.5	7.3	269	3	2
3	65.868	V	39.1	-18.8	20.3	29.5	9.2	172	258	2
4	623.131	H	21.6	-4.5	17.1	35.5	18.4	276	232	1
5	710.940	V	32.6	-3.0	29.6	35.5	5.9	195	219	2
6	710.940	H	35.0	-3.6	31.4	35.5	4.1	100	80	1
7	847.414	V	23.7	-1.0	22.7	35.5	12.8	250	136	2
8	888.531	H	29.9	-1.6	28.3	35.5	7.2	104	176	1

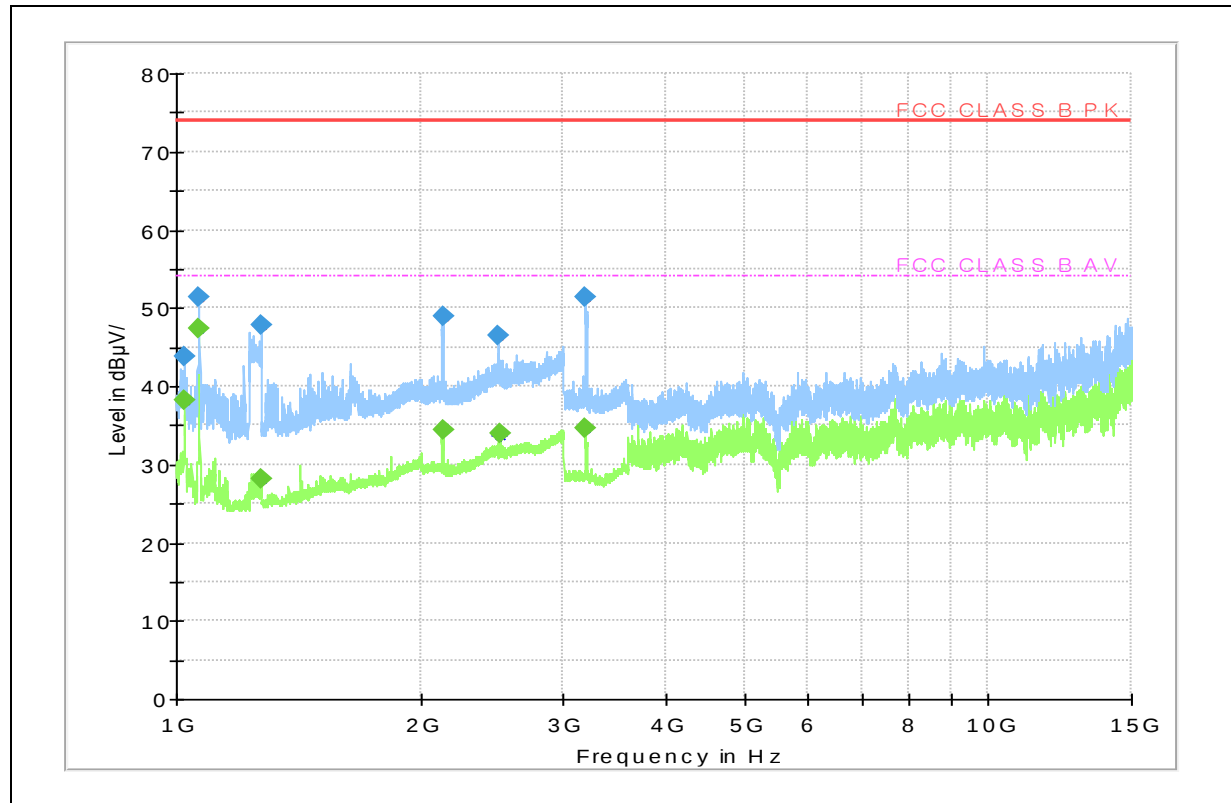
Note) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 10 m, Antenna Height : 1 to 4 meters

Level (QP) = Reading (QP) + c.f (Antenna Factor + Cable Loss - Amp. Gain)

Margin (QP) = Limit - Level (QP)

QP = Quasi-Peak, c.f = Correction Factor

- Frequencies above 1 GHz

Frequency (MHz)	PK (dBμV/m)	CAV (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Height (cm)	Pol	Azimuth (deg)	Corr. (dB)
1 024.000	---	38.2	54.0	15.8	100.0	H	36.0	6.8
1 024.400	43.9	---	74.0	30.1	100.0	H	36.0	6.8
1 066.000	51.4	---	74.0	22.6	100.0	H	0.0	6.4
1 066.400	---	47.3	54.0	6.7	100.0	H	15.0	6.4
1 271.200	---	28.2	54.0	25.8	100.0	V	175.0	7.4
1 272.400	47.8	---	74.0	26.2	100.0	V	175.0	7.4
2 132.400	---	34.5	54.0	19.5	100.0	H	237.0	12.8
2 133.600	49.0	---	74.0	25.0	100.0	H	194.0	12.8
2 492.400	46.5	---	74.0	27.5	100.0	H	258.0	14.4
2 500.000	---	33.9	54.0	20.1	100.0	V	294.0	14.4
3 184.500	51.4	---	74.0	22.6	100.0	H	230.0	1.2
3 186.000	---	34.6	54.0	19.4	100.0	H	230.0	1.2

Note 1) Receiving antenna polarization : Horizontal, Vertical

Test Distance : 3 m, Antenna Height : 1 to 4 meters

Level (PK and/or CAV) = Reading (PK and/or CAV) + Corr. (Antenna Factor + Cable Loss - Amp. Gain)

Margin (PK and/or CAV) = Limit – Level (PK and/or CAV)

PK = Peak, CAV = CISPR-Average, Corr. = Correction Factor